

# 32,768 x 8 HIGH-SPEED CMOS EPROM

**JANUARY 1998** 

### **FEATURES**

- · Fast read access time: 45 ns
- Pin compatible with the IS27C256
- · Low power consumption
  - 50 μA CMOS standby
- Industrial and commercial temperature ranges available
- · High-speed write programming
  - Typically less than four seconds
- 5V ±10% power supply tolerance available
- JEDEC-approved pinout
- Standard 28-pin DIP, TSOP, and 32-pin PLCC packages

### **DESCRIPTION**

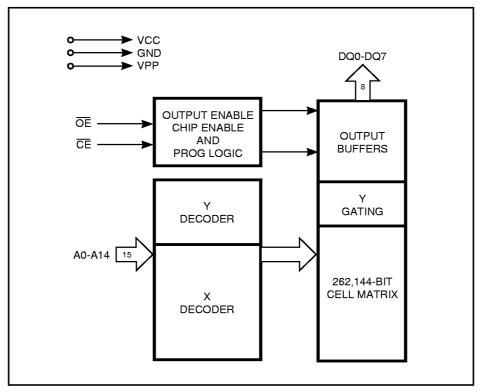
The *ISSI* IS27HC256 is an ultra-high-speed 256K-bit CMOS Programmable Read-Only Memory. It utilizes the standard JEDEC pinout making it functionally compatible with the IS27C256, but with significantly faster access capability. This superior random access capability results from a focused high-speed design. This offers users bipolar speeds with higher density, lower cost and proven reliability.

The device is ideal for use with the faster processors. The IS27HC256 completely eliminates performance-draining wait states without using bank-interleaving and caching techniques. Designers may take full advantage of high-speed digital signal processors and microprocessors by allowing code to be executed at full speed directly out of EPROM. Typical applications include laser printers, graphics, I/O cards, and digital signal processing.

The IS27HC256 uses *ISSI's* write programming algorithm which allows the entire chip to be programmed in typically less than four seconds.

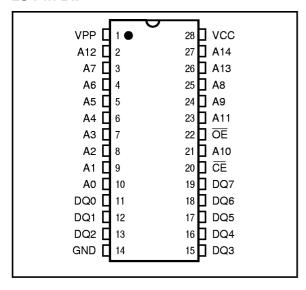
This product is available in One-Time Programmable (OTP) PDIP, TSOP and PLCC packages over commercial and industrial temperature ranges.

### **FUNCTIONAL BLOCK DIAGRAM**

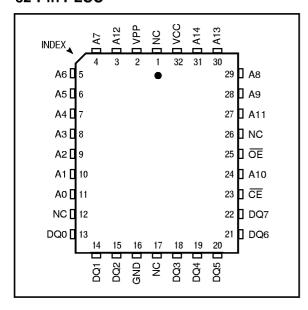


ISSI reserves the right to make changes to its products at any time without notice in order to improve design and supply the best possible product. We assume no responsibility for any errors which may appear in this publication. © Copyright 1997, Integrated Silicon Solution, Inc.

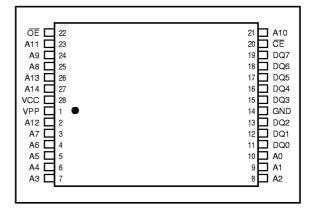
# PIN CONFIGURATIONS 28-Pin DIP



### 32-Pin PLCC



#### 28-Pin TSOP



### **PIN DESCRIPTIONS**

A0-A14	Address Inputs	
CE	Chip Enable Input	
DQ0-DQ7	Data Inputs/Outputs	
ŌĒ	Output Enable Input	
Vcc	Power Supply Voltage	
<b>V</b> PP	Program Supply Voltage	
GND	Ground	
NC	No Internal Connection	

### **FUNCTIONAL DESCRIPTION**

### Programming the IS27HC256

Upon delivery, the IS27HC256 has 262,144 bits in the "ONE", or HIGH state. "ZEROs" are loaded into the IS27HC256 through the procedure of programming.

The programming mode is entered when  $12.5 \pm 0.25V$  is applied to the VPP pin, Vcc = 6V,  $\overline{CE}$  is at VIL, and  $\overline{OE}$  is at VIH. For programming, the data to be programmed is applied eight bits in parallel to the data output pins.

The write programming algorithm reduces programming time by using 100  $\mu s$  programming pulses followed by a byte verification to determine whether the byte has been successfully programmed. If the data does not verify, an additional pulse is applied for a maximum of 25 pulses. This process is repeated while sequencing through each address of the EPROM.

The write programming algorithm programs and verifies at Vcc = 6V and Vpp = 12.5V. After the final address is completed, all byte are compared to the original data with Vcc = 5.25V.

### **Program Inhibit**

Programming of multiple IS27HC256s in parallel with different data is also easily accomplished. Except for  $\overline{CE}$ , all like inputs of the parallel IS27HC256 may be common. A TTL low-level program pulse applied to an IS27HC256  $\overline{CE}$  input with VPP = 12.5  $\pm$  0.25V, will program the IS27HC256. A high-level  $\overline{CE}$  input inhibits the other IS27HC256 from being programmed.

### **Program Verify**

A verify should be performed on the programmed bits to determine that they were correctly programmed. The verify should be performed with  $\overline{CE}$  at V<sub>IH</sub>,  $\overline{OE}$  at V<sub>IL</sub> with V<sub>PP</sub> = 12.5V  $\pm$  0.25V.

#### **Auto Select Mode**

The auto select mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its corresponding programming algorithm. This mode is functional in the 25°C  $\pm$ 5°C ambient temperature range that is required when programming the IS27HC256.

To activate this mode, the programming equipment must force 12.0  $\pm$  0.5V on address line A9 of the IS27HC256. Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from V<sub>IL</sub> to V<sub>IH</sub>. All other address lines must be held at V<sub>IL</sub> during auto select mode.

Byte 0 (A0 =  $V_{\rm IL}$ ) represents the manufacturer code, and byte 1 (A0 =  $V_{\rm IH}$ ), the device identifier code. For the IS27HC256, these two identifier bytes are given in the Mode Select table. All identifiers manufacturer and device codes will possess odd parity, with the MSB (DQ7) defined as the parity bit.

#### **Read Mode**

The IS27HC256 has two control functions, both of which must be logically satisfied in order to obtain data at the outputs. Chip Enable ( $\overline{CE}$ ) is the power control and should be used for device selection. Assuming that addresses are stable, address access time (tacc) is equal to the delay from  $\overline{CE}$  to output (tce). Output Enable ( $\overline{OE}$ ) is the output control and should be used to get data to the output pins, independent of device selection. Data is available at the outputs toe after the falling edge of  $\overline{OE}$  assuming that  $\overline{CE}$  has been LOW and addresses have been stable for at least tacc – toe.

#### **Standby Mode**

The IS27HC256 has a standby mode which reduces the maximum Vcc active current. It is placed in standby mode when  $\overline{CE}$  is at V<sub>IH</sub>. The amount of current drawn in standby mode depends on the frequency and the number of address pins switching. The IS27HC256 is specified with 50% of the address lines toggling at 5 MHz. A reduction of the frequency or quantity of address lines toggling will significantly reduce the actual standby current.

### **Output OR-Tieing**

To accommodate multiple memory connections, a twoline control function is provided to allow for:

- 1. Low memory power dissipation, and
- 2. Assurance that output bus contention will not occur.

It is recommended that  $\overline{CE}$  be decoded and used as the primary device-selecting function, while  $\overline{OE}$  be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in their low-power standby mode and that the output pins are only active when data is desired from a particular memory device.

### **System Applications**

During the switch between active and standby conditions, transient current peaks are produced on the rising and falling edges of Chip Enable. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device at a minimum, a  $0.1~\mu F$  ceramic capacitor (high-frequency, low inherent inductance) should be used on each device between Vcc and GND to minimize transient effects. In addition, to overcome the voltage drop caused by the inductive effects of the printed circuit board traces on EPROM arrays, a  $4.7~\mu F$  bulk electrolytic capacitor should be used between Vcc and GND for each eight devices. The location of the capacitor should be close to where the power supply is connected to the array.

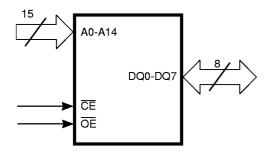
### TRUTH TABLE(1,2)

Mode	CE	ŌĒ	<b>V</b> PP	A0	<b>A</b> 9	Outputs
Read	VIL	VIL	<b>V</b> cc	Х	Χ	<b>D</b> ouт
Output Disable	VIL	VIH	Vcc	Χ	Χ	Hi-Z
Standby	VIH	Х	Vcc	Х	Х	Hi-Z
Program	VIL	VIH	<b>V</b> PP	Х	Х	Din
Program Verify	Vін	VIL	$V_{PP}$	Χ	Χ	<b>D</b> ouт
Program Inhibit	VIH	Vін	$V_PP$	Χ	Χ	Hi-Z
Auto Select <sup>(3,5)</sup> Manufacturer Code	VIL	VIL	Vcc	VIL	Vн	D5H
Device Code	$V_{IL}$	$V_{IL}$	Vcc	$V_IH$	Vн	10H

#### Notes:

- 1.  $V_H = 12.0V \pm 0.5V$ .
- 2. X = Either VIH or VIL.
- 3. A1-A8 = A10-A14 = VIL.
- 4. See DC Programming Characteristics for VPP voltage during programming.
- 5. The IS27HC256 can use the same write program as other IS27HC256 or IS27256 devices.

### **LOGIC SYMBOL**



### **ABSOLUTE MAXIMUM RATINGS(1)**

Symbol	Parameter	Value	Unit
<b>V</b> TERM	Terminal Voltage with Respect to GND		
	All pins except A9 and VPP	$-0.6$ to Vcc + $0.5^{(2)}$	V
	VPP	$Vcc - 0.3$ to $13.5^{(2,3)}$	V
	A9	-0.6 to 13.5 <sup>(2,3)</sup>	V
	Vcc	-0.6 to 7.0 <sup>(2)</sup>	V
Ta	Ambient Temperature with Power Applied	-65 to +125	°C
Тѕтс	Storage Temperature (OTP)	-65 to +125	°C
Tstg	Storage Temperature (All others)	-65 to +150	°C

#### **Notes**

- Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the
  device. This is a stress rating only and functional operation of the device at these or any other conditions above
  those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum
  rating conditions for extended periods may affect reliability.
- 2. Minimum DC input voltage is -0.5V. During transitions, inputs may undershoot to -2.0V for periods less than 10 ns. Maximum DC voltage on output pins is Vcc + 0.5V which may overshoot to Vcc + 2.0V for periods less than 10 ns.
- 3. Maximum DC voltage on A9 or VPP may overshoot to +13.5V for periods less than 10 ns.

#### **OPERATING RANGE**

Range	Ambient Temperature	Vcc
Commercial	0°C to +70°C	5V ± 10%
Industrial(1)	–40°C to +85°C	5V ± 10%

#### Note:

1. Operating ranges define those limits between which the functionally of the device is guaranteed.

### DC ELECTRICAL CHARACTERISTICS<sup>(1,2,3)</sup> (Over Operating Range)

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
Vон	Output HIGH Voltage	Vcc = Min., IoH = -4.0 mA	2.4	_	V
Vol	Output LOW Voltage	Vcc = Min., loL = 8.0 mA	_	0.45	V
VIH	Input HIGH Voltage(4)		2.0	Vcc + 0.5	V
VIL	Input LOW Voltage(4)		-0.3	0.8	V
	Input Load Current	VIN = 0V to +Vcc	_	5.0	μA
llo	Output Leakage Current	Vout = 0V to +Vcc	_	10	μΑ

#### Notes:

- 1. Vcc must be applied simultaneously or before VPP and removed simultaneously or after VPP. Never try to force VPP LOW to 1V below Vcc. Manufacturer suggests to tie VPP and Vcc together during the READ operation.
- 2. Caution: the IS27HC256 must not be removed from (or inserted into) a socket when Vcc or VPP is applied.
- 3. Minimum DC input voltage is -0.5V. During transitions, the inputs may undershoot to -2.0V for periods less than 10 ns. Maximum DC voltage on output pins is Vcc + 0.5V which may overshoot to Vcc + 2.0V for periods less than 10 ns.
- 4. Tested under static DC conditions.

### POWER SUPPLY CHARACTERISTICS<sup>(1,2,5)</sup> (Over Operating Range)

Symbol	Parameter	Test Conditions		Min.	Max.	Unit
lcc1	Vcc Operating Supply Current <sup>(3)</sup>	Vcc = Max., $\overline{CE}$ = VIL lout = 0 mA, f = 5 MHz (Open outputs)	Commercial Industrial	_	15 20	mA
IPP1	VPP Current During Read <sup>(4)</sup>	$V_{CC} = Max., \overline{CE} = \overline{OE} = V_{IL}$ $V_{PP} = V_{CC}$		_	100	μА
Iccsb0	Vcc CMOS Standby Current	$\overline{\text{CE}} \ge \text{Vcc} - 0.3\text{V}$ All pins $\ge \text{Vcc} - 0.3\text{V}$ or $\le 0.3\text{V}$	$\overline{\text{CE}} \ge \text{Vcc} - 0.3\text{V}$ All pins $\ge \text{Vcc} - 0.3\text{V}$ or $\le 0.3\text{V}$		50	μΑ
IccsB1	Vcc TTL Standby Current	CE ≥ VIH All pins = VIH or VIL (TTL Leve	·I)	_	1	mA

#### Notes:

- 1. Vcc must be applied simultaneously or before VPP and removed simultaneously or after VPP. Never try to force VPP LOW to 1V below Vcc. Manufacturer suggests to tie VPP and Vcc together during the READ operation.
- 2. Caution: the IS27HC256 must not be removed from (or inserted into) a socket when Vcc or VPP is applied.
- 3. Icc1 is tested with  $\overline{OE} = V H$  to simulate open outputs.
- 4. Maximum active power usage is the sum of Icc and IPP.
- 5. Minimum DC input voltage is -0.5V. During transitions, the inputs may undershoot to -2.0V for periods less than 10 ns. Maximum DC voltage on output pins is Vcc + 0.5V which may overshoot to Vcc + 2.0V for periods less than 10 ns.



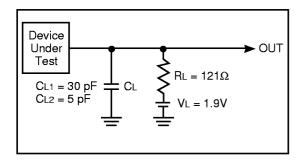
### **CAPACITANCE**(1,2,3)

			D	IP	PL	CC	
Symbol	Parameter	Conditions	Тур.	Max.	Тур.	Max.	Unit
Cin	Input Capacitance	VIN = 0V	6	12	6	10	pF
Соит	Output Capacitance	Vout = 0V	8	12	6	10	pF

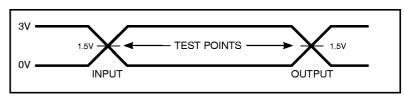
#### Notes:

- 1. Typical values are for nominal supply voltage.
- 2. This parameter is only sampled, but not 100% tested.
- 3. Test conditions: TA = 25°C, f = 1 MHz.

### **SWITCHING TEST CIRCUIT**



### **SWITCHING TEST WAVEFORM**



#### Notes:

AC Testing:

- 1. Inputs are driven at 3.0V for a logic "1" and 0V for a logic "0".
- 2. Input pulse rise and fall times are ≥ 1.5V/ns.

### **SWITCHING CHARACTERISTICS**(1,2,3,4) (Over Operating Range)

JEDEC	Std.			-4	15	-{	55	-7	70	
Symbol	Symbol	Parameter	<b>Test Conditions</b>	Min.	Max.	Min.	Max.	Min.	Max.	Unit
tavqa	tacc	Address to Output Delay	$\overline{CE} = \overline{OE} = V_{IL}$ $C_L = C_{L1}$	_	45	_	55	_	70	ns
<b>t</b> elq <b>v</b>	tce	Chip Enable to Output Delay	OE = VIL CL = CL1	_	45	_	55	_	70	ns
tglqv	toe	Output Enable to Output Delay	CE = VIL CL = CL1	_	20	_	25	_	35	ns
teноz, tgнqz	t <sub>DF</sub> <sup>(2)</sup>	Chip Enable HIGH or Output Enable HIGH, whichever comes first, to Output Float	CL = CL2	0	20	0	25	0	30	ns
tavox	tон	Output Hold from Address, CE or OE whichever occured first		0	_	0	_	0	_	ns

### Notes:

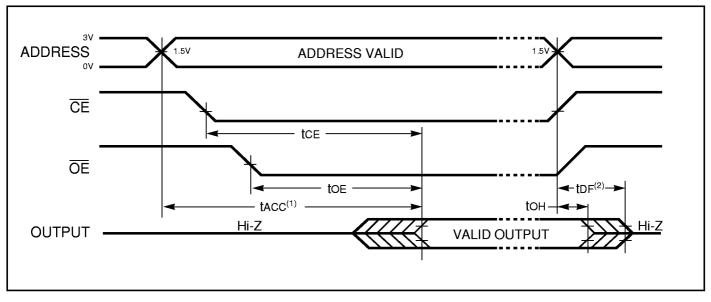
- 1. Vcc must be applied simultaneously or before VPP and removed simultaneously or after VPP.
- 2. This parameter is only sampled, not 100% tested.
- 3. Caution: The IS27HC256 must not be removed from (or inserted into) a socket or board when VPP or Vcc applied.
- 4. Output Load: 1 TTL gate and  $C = C_L$ .

Input Rise and Fall times: 2 ns.

Input Pulse Levels: 0V to 3V.

Timing Measurement Reference Level: 1.5V for inputs and outputs.

### **SWITCHING WAVEFORMS**



#### Notes:

- OE may be delayed up to tacc to after the falling edge of CE without impact on tacc.
   top is specified from OE or CE, whichever occurs first.

## DC PROGRAMMING CHARACTERISTICS(1,2,3,4) (TA = +25°C $\pm$ 5°C)

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
Vон	Output HIGH Voltage During Verify	Іон = –400 μА	2.4	_	V
<b>V</b> OL	Output LOW Voltage During Verify	IoL = 2.1 mA	_	0.45	٧
VIH	Input HIGH Voltage		2.0	Vcc + 0.5	٧
VIL	Input LOW Voltage (All Inputs)		-0.3	0.8	٧
VH	A9 Auto Select Voltage		11.5	12.5	٧
lu	Input Current (All Inputs)	VIN = VIL Or VIH	_	10.0	μΑ
Icc	Vcc Supply Current (Program & Verify)		_	50	mA
Ірр	VPP Supply Current	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}$	_	30	mA
Vcc	Supply Voltage		5.75	6.25	٧
<b>V</b> PP	Programming Voltage		12.25	12.75	٧



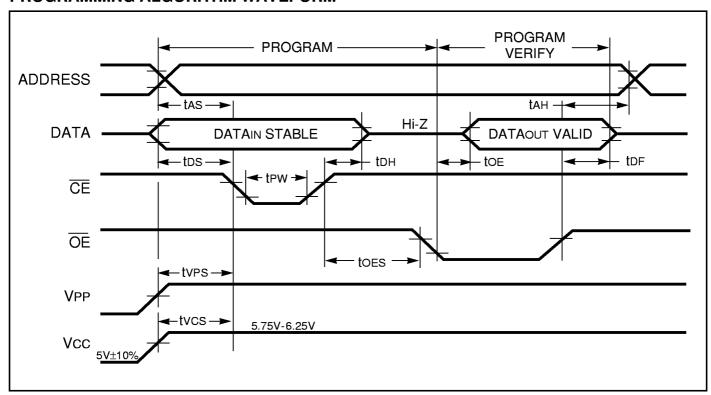
### **SWITCH PROGRAMMING CHARACTERISTICS**(1,2,3,4) (TA = +25°C $\pm$ 5°C)

JEDEC Symbol	Std. Symbol	Parameter	Min.	Max.	Unit
tavel	tas	Address Setup Time	2	_	μs
<b>t</b> EHGL	<b>t</b> oн	OE Hold Time	2	_	μs
<b>t</b> DVEL	<b>t</b> DS	Data Setup Time	2	_	μs
<b>t</b> GHAX	<b>t</b> ah	Address Hold Time	0	_	μs
<b>t</b> EHDX	<b>t</b> DH	Data Hold Time	2	_	μs
<b>t</b> ehqz	<b>t</b> DF	OE to Output Float Delay	0	130	ns
tvps	tvps	VPP Setup Time	2	_	μs
teleh1	tpw	CE Program Pulse Width	95	105	μs
tvcs	tvcs	Vcc Setup Time	2	_	μs
tGLEL	toes	OE Setup Time	2	_	μs
<b>t</b> ELQV	<b>t</b> 0E	Data Valid from OE	_	150	ns

#### Notes:

- 1. Vcc must be applied simultaneously or before VPP and removed simultaneously or after VPP.
- 2. VPP must be ≥ Vcc during the entire programming and verifying procedure.
- 3. When programming IS27HC256, a 0.1 μF capacitor is required across VPP and ground to suppress spurious voltage transients which may damage the device.
- 4. Programming characteristics are sampled but not 100% tested at worst-case conditions.

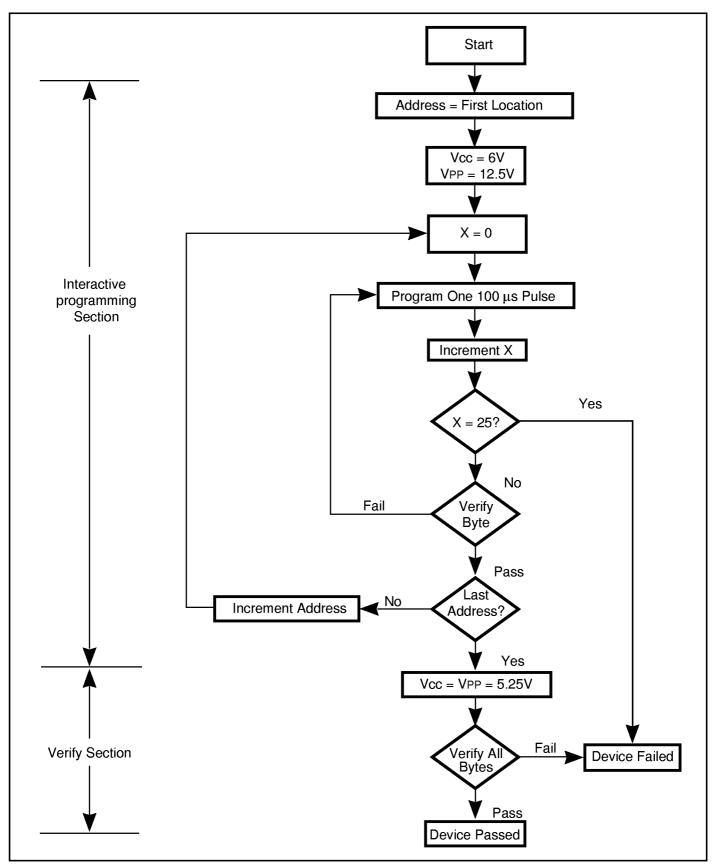
### PROGRAMMING ALGORITHM WAVEFORM(1,2)



#### Notes:

- 1. The timing reference level is 1.5V for inputs and outputs.
- 2. toe and topp are characteristics of the device but must be accommodated by the programmer.

### **PROGRAMMING FLOW CHART**



### **ORDERING INFORMATION**

Commercial Range: 0°C to +70°C

Speed (ns)	Order Part Number	Package
45	IS27HC256-45W IS27HC256-45PL IS27HC256-45T	600-mil Plastic DIP PLCC – Plastic Leaded Chip Carrier TSOP
55	IS27HC256-55W IS27HC256-55PL IS27HC256-55T	600-mil Plastic DIP PLCC – Plastic Leaded Chip Carrier TSOP
70	IS27HC256-70W IS27HC256-70PL IS27HC256-70T	600-mil Plastic DIP PLCC – Plastic Leaded Chip Carrier TSOP

### **ORDERING INFORMATION**

Industrial Range: -40°C to +85°C

Speed (ns)	Order Part Number	Package
45	IS27HC256-45PLI IS27HC256-45TI	PLCC – Plastic Leaded Chip Carrier TSOP
55	IS27HC256-55PLI IS27HC256-55TI	PLCC – Plastic Leaded Chip Carrier TSOP
70	IS27HC256-70PLI IS27HC256-70TI	PLCC – Plastic Leaded Chip Carrier TSOP



# Integrated Silicon Solution, Inc.

2231 Lawson Lane Santa Clara, CA 95054 Fax: (408) 588-0806

Toll Free: 1-800-379-4774 http://www.issiusa.com